

B/O Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	Docket Number TOME3001/EM/7026	Serial Number
	Applicant Kouji TOMETSUKA	
	Filing Date Herewith - July 25, 2001	Group

U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
<i>Rk</i>	5,248,886	9/1993	Asakawa et al.	250	442.11	February 27, 1992

J1040 U.S. PTO
 09/11/01
 07/25/01

Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
						Yes	No

Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)

		Yong-Beom LEE, Bum-Jae YOU, Seong-Whan LEE, Kwang-Bae KIM, <i>Real-Time Face-Tracking Algorithm Robust To Illumination Variations</i> , Proceedings Of The KIEE Summer Annual Conference 2000, July 17, 2000, pages 3037-3040 with cover sheet

Examiner

Rk

Date Considered

11-8-2002

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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